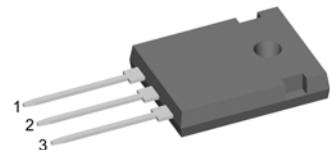
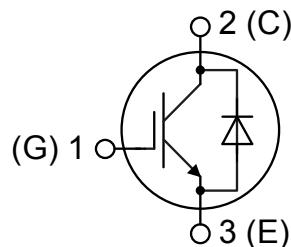


**XPT IGBT**

$V_{CES}$  = 1200V  
 $I_{C25}$  = 78A  
 $V_{CE(sat)}$  = 1.8V

**Copack****Part number****IXA45IF1200HB**

Backside: collector

**Features / Advantages:**

- Easy paralleling due to the positive temperature coefficient of the on-state voltage
- Rugged XPT design (Xtreme light Punch Through) results in:
  - short circuit rated for 10  $\mu$ sec.
  - very low gate charge
  - low EMI
  - square RBSOA @ 3x  $I_c$
- Thin wafer technology combined with the XPT design results in a competitive low  $V_{CE(sat)}$
- SONIC™ diode
  - fast and soft reverse recovery
  - low operating forward voltage

**Applications:**

- AC motor drives
- Solar inverter
- Medical equipment
- Uninterruptible power supply
- Air-conditioning systems
- Welding equipment
- Switched-mode and resonant-mode power supplies
- Inductive heating, cookers
- Pumps, Fans

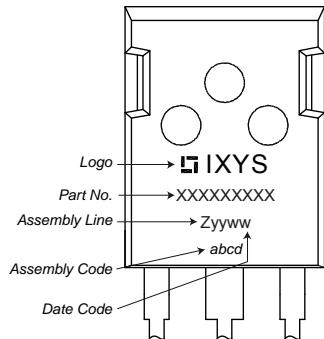
**Package: TO-247**

- Industry standard outline
- RoHS compliant
- Epoxy meets UL 94V-0

IGBT			Ratings				
Symbol	Definition	Conditions	min.	typ.	max.	Unit	
$V_{CES}$	collector emitter voltage	$T_{VJ} = 25^\circ C$			1200	V	
$V_{GES}$	max. DC gate voltage				$\pm 20$	V	
$V_{GEM}$	max. transient gate emitter voltage				$\pm 30$	V	
$I_{C25}$	collector current	$T_c = 25^\circ C$			78	A	
$I_{C80}$		$T_c = 80^\circ C$			45	A	
$P_{tot}$	total power dissipation	$T_c = 25^\circ C$			325	W	
$V_{CE(sat)}$	collector emitter saturation voltage	$I_c = 35 A; V_{GE} = 15 V$	$T_{VJ} = 25^\circ C$		1.8	V	
			$T_{VJ} = 125^\circ C$		2.1	V	
$V_{GE(th)}$	gate emitter threshold voltage	$I_c = 1.5 mA; V_{GE} = V_{CE}$	$T_{VJ} = 25^\circ C$	5.4	5.9	6.5	V
$I_{CES}$	collector emitter leakage current	$V_{CE} = V_{CES}; V_{GE} = 0 V$	$T_{VJ} = 25^\circ C$		0.1	mA	
			$T_{VJ} = 125^\circ C$		0.1	mA	
$I_{GES}$	gate emitter leakage current	$V_{GE} = \pm 20 V$			500	nA	
$Q_{G(on)}$	total gate charge	$V_{CE} = 600 V; V_{GE} = 15 V; I_c = 35 A$			106	nC	
$t_{d(on)}$	turn-on delay time	inductive load $V_{CE} = 600 V; I_c = 35 A$ $V_{GE} = \pm 15 V; R_G = 27 \Omega$			70	ns	
$t_r$	current rise time				40	ns	
$t_{d(off)}$	turn-off delay time				250	ns	
$t_f$	current fall time				100	ns	
$E_{on}$	turn-on energy per pulse				3.8	mJ	
$E_{off}$	turn-off energy per pulse				4.1	mJ	
<b>RBSOA</b>	reverse bias safe operating area	$V_{GE} = \pm 15 V; R_G = 27 \Omega$	$T_{VJ} = 125^\circ C$				
$I_{CM}$		$V_{CEmax} = 1200 V$			105	A	
<b>SCSOA</b>	short circuit safe operating area	$V_{CEmax} = 900 V$					
$t_{sc}$	short circuit duration	$V_{CE} = 900 V; V_{GE} = \pm 15 V$	$T_{VJ} = 125^\circ C$		10	μs	
$I_{sc}$	short circuit current	$R_G = 27 \Omega$ ; non-repetitive			140	A	
$R_{thJC}$	thermal resistance junction to case				0.38	K/W	
$R_{thCH}$	thermal resistance case to heatsink				0.25	K/W	
Diode							
$V_{RRM}$	max. repetitive reverse voltage	$T_{VJ} = 25^\circ C$			1200	V	
$I_{F25}$	forward current	$T_c = 25^\circ C$			60	A	
$I_{F80}$		$T_c = 80^\circ C$			33	A	
$V_F$	forward voltage	$I_F = 30 A$	$T_{VJ} = 25^\circ C$		2.20	V	
			$T_{VJ} = 125^\circ C$		1.95	V	
$I_R$	reverse current	$V_R = V_{RRM}$	$T_{VJ} = 25^\circ C$		*	mA	
	* not applicable, see $I_{CES}$ value above		$T_{VJ} = 125^\circ C$		*	mA	
$Q_{rr}$	reverse recovery charge	$V_R = 600 V$ $-di_F/dt = -600 A/\mu s$ $I_F = 30 A; V_{GE} = 0 V$			3.5	μC	
$I_{RM}$	max. reverse recovery current				30	A	
$t_{rr}$	reverse recovery time				350	ns	
$E_{rec}$	reverse recovery energy				0.9	mJ	
$R_{thJC}$	thermal resistance junction to case				0.7	K/W	
$R_{thCH}$	thermal resistance case to heatsink				0.25	K/W	

Package TO-247			Ratings		
Symbol	Definition	Conditions	min.	typ.	max.
		per terminal			Unit
$I_{RMS}$	RMS current				70 A
$T_{VJ}$	virtual junction temperature		-40		150 °C
$T_{op}$	operation temperature		-40		125 °C
$T_{stg}$	storage temperature		-40		150 °C
Weight				6	g
$M_D$	mounting torque		0.8		1.2 Nm
$F_c$	mounting force with clip		20		120 N

## Product Marking

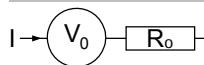


## Part number

I = IGBT  
 X = XPT IGBT  
 A = Gen 1 / std  
 45 = Current Rating [A]  
 IF = Copack  
 1200 = Reverse Voltage [V]  
 HB = TO-247AD (3)

Ordering	Part Number	Marking on Product	Delivery Mode	Quantity	Code No.
Standard	IXA45IF1200HB	IXA45IF1200HB	Tube	30	507837

## Equivalent Circuits for Simulation

*\* on die level* $T_{VJ} = 150 \text{ }^{\circ}\text{C}$ 

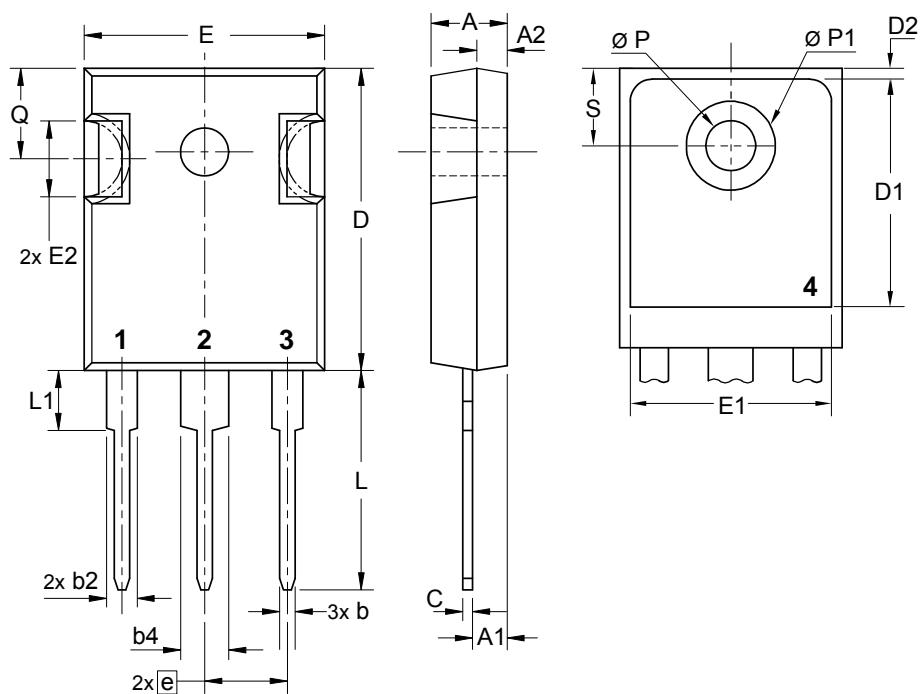
IGBT

Diode

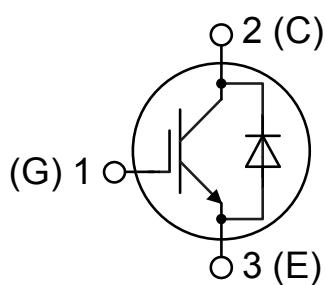
$V_{0\max}$  threshold voltage  
 $R_{0\max}$  slope resistance \*

1.1	1.25	V
39	28.3	mΩ

## Outlines TO-247



Sym.	Inches min. max.	Millimeter min. max.
A	0.185 0.209	4.70 5.30
A1	0.087 0.102	2.21 2.59
A2	0.059 0.098	1.50 2.49
D	0.819 0.845	20.79 21.45
E	0.610 0.640	15.48 16.24
E2	0.170 0.216	4.31 5.48
e	0.215 BSC	5.46 BSC
L	0.780 0.800	19.80 20.30
L1	- 0.177	- 4.49
Ø P	0.140 0.144	3.55 3.65
Q	0.212 0.244	5.38 6.19
S	0.242 BSC	6.14 BSC
b	0.039 0.055	0.99 1.40
b2	0.065 0.094	1.65 2.39
b4	0.102 0.135	2.59 3.43
c	0.015 0.035	0.38 0.89
D1	0.515 -	13.07 -
D2	0.020 0.053	0.51 1.35
E1	0.530 -	13.45 -
Ø P1	- 0.29	- 7.39



## IGBT

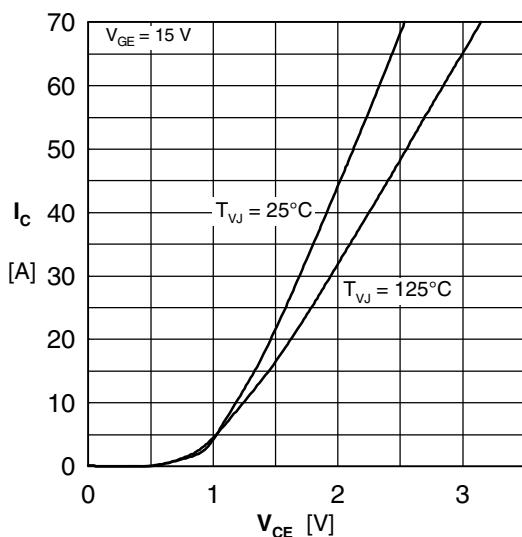


Fig. 1 Typ. output characteristics

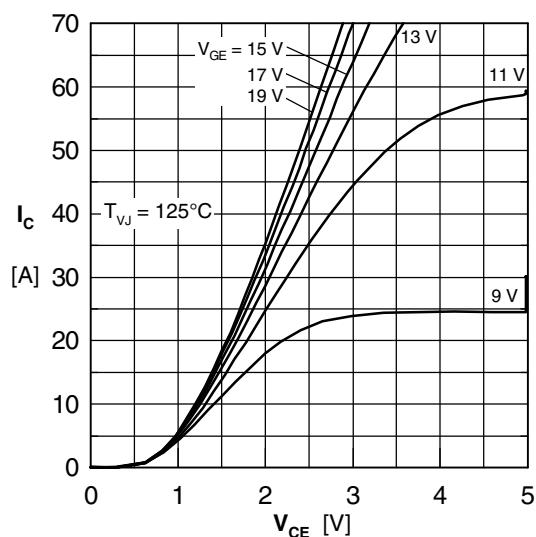


Fig. 2 Typ. output characteristics

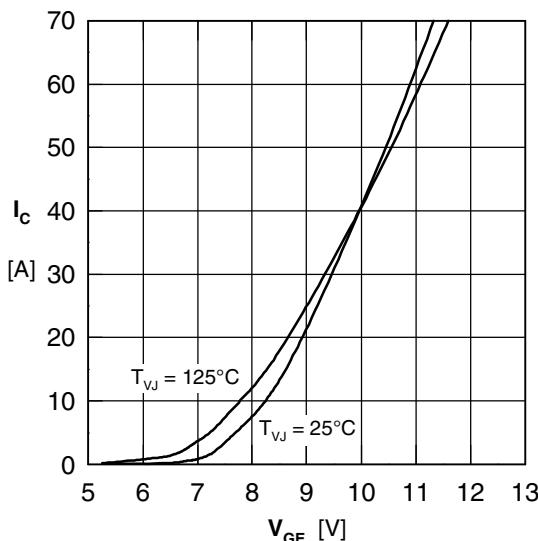


Fig. 3 Typ. transfer characteristics

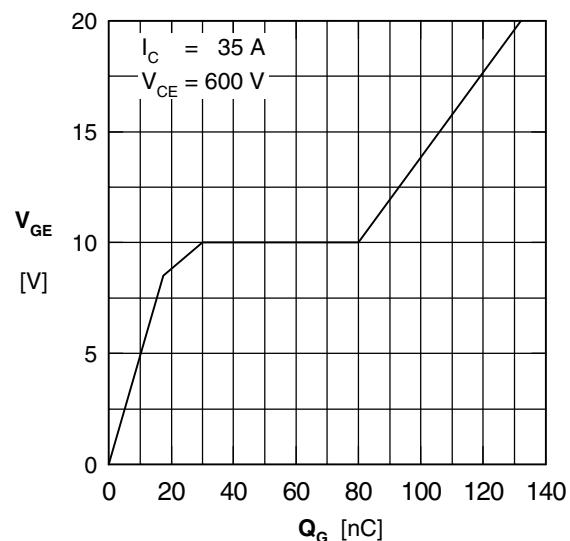


Fig. 4 Typ. turn-on gate charge

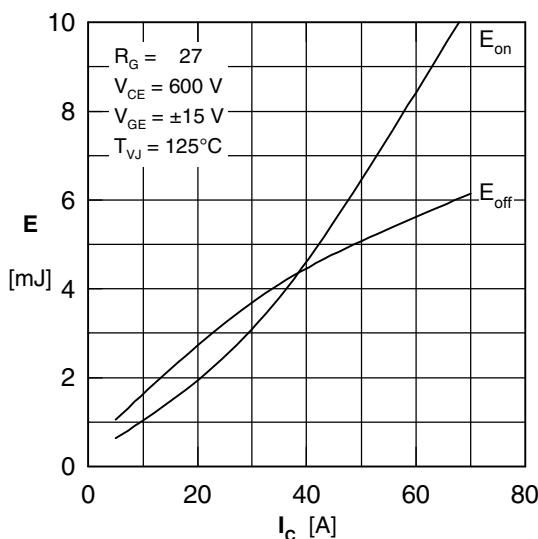


Fig. 5 Typ. switching energy vs. collector current

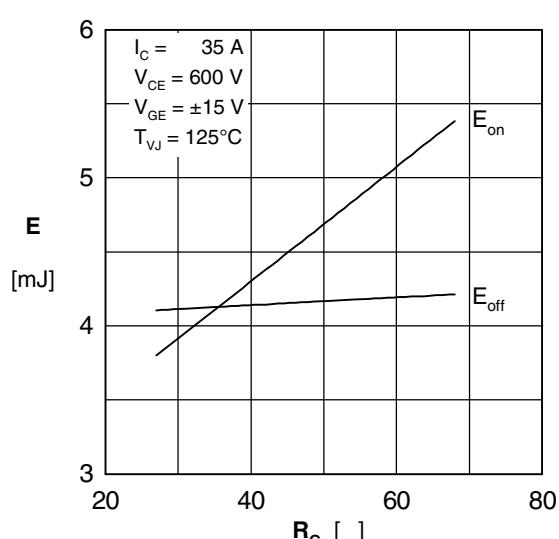


Fig. 6 Typ. switching energy vs. gate resistance

## Diode

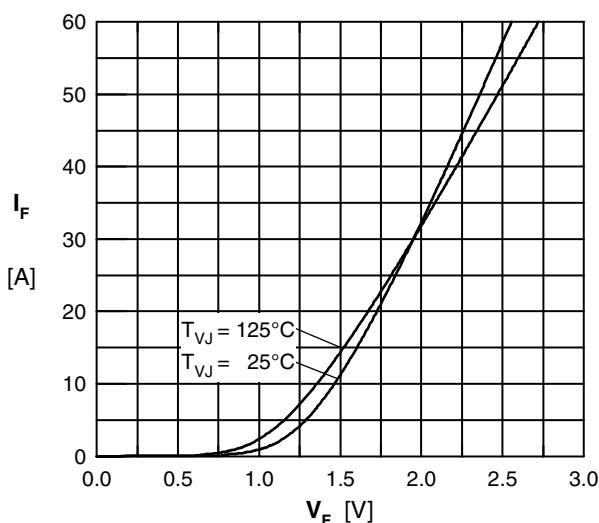
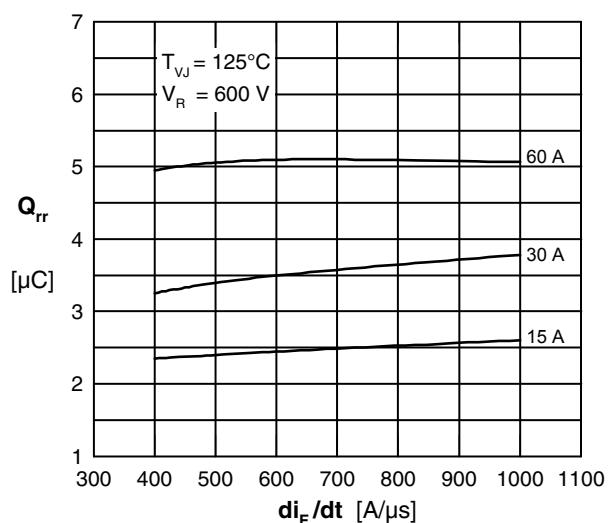
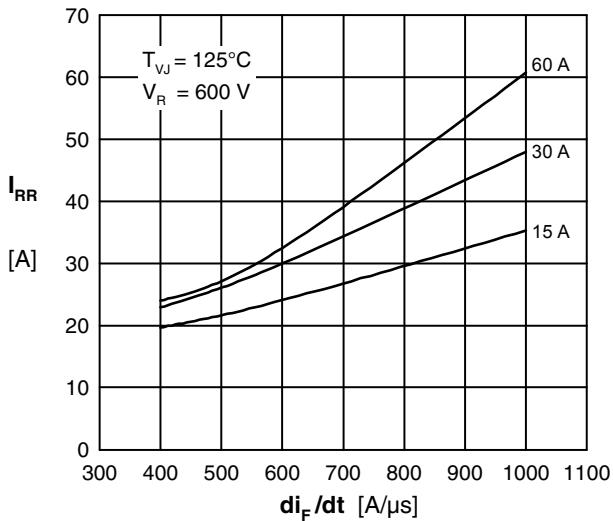
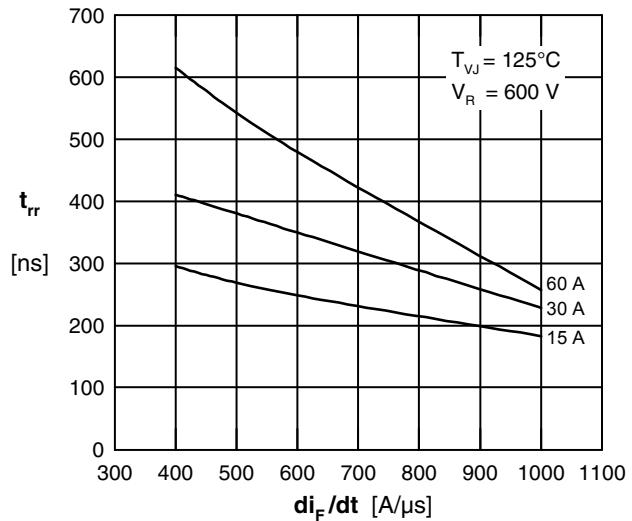
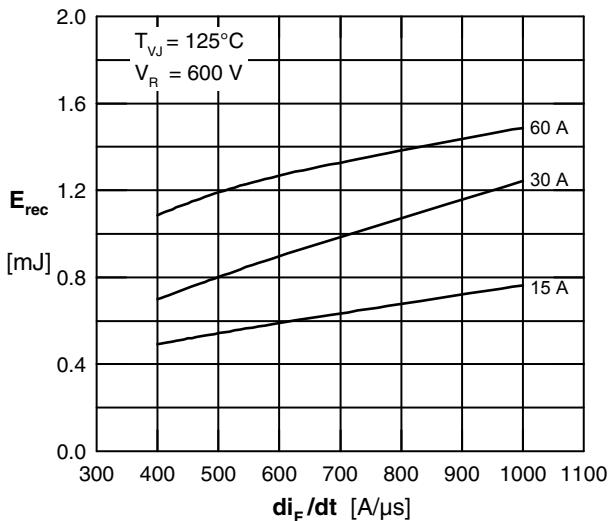
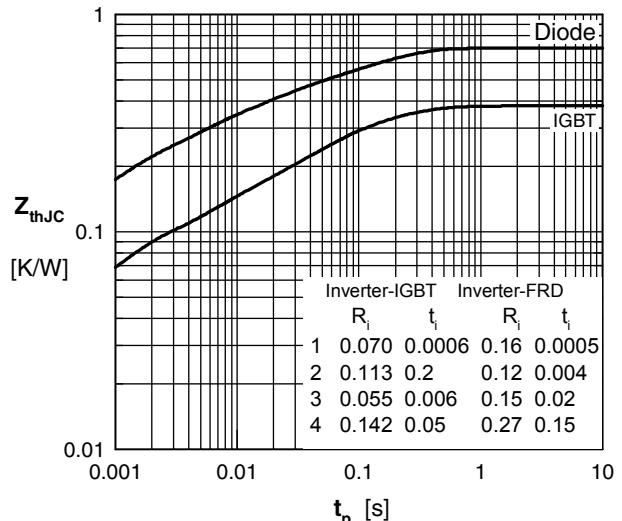
Fig. 7 Typ. Forward current versus  $V_F$ Fig. 8 Typ. reverse recov.charge  $Q_{rr}$  vs.  $di/dt$ Fig. 9 Typ. peak reverse current  $I_{rr}$  vs.  $di/dt$ Fig. 10 Typ. recovery time  $t_{rr}$  versus  $di/dt$ Fig. 5 Typ. recovery energy  $E_{rec}$  versus  $di/dt$ 

Fig. 12 Typ. transient thermal impedance